BLF6G13L-250P; BLF6G13LS-250P

Power LDMOS transistor

Rev. 3 — 14 October 2011

Product data sheet

1. Product profile

1.1 General description

250 W LDMOS power transistor intended for CW applications at a frequency of 1.3 GHz.

Table 1. Test information

Typical RF performance at $T_{case} = 25$ °C; $I_{Dq} = 100$ mA; in a class-AB production test circuit.

| Mode of operation | f | V _{DS} | P _{L(1dB)} | Gp | η _D |
|-------------------|-------|-----------------|---------------------|------|----------------|
| | (GHz) | (V) | (W) | (dB) | (%) |
| CW | 1.3 | 50 | 250 | 17 | 56 |

1.2 Features and benefits

- Typical CW performance at a frequency of 1.3 GHz, a supply voltage of 50 V, an I_{Dq} of 100 mA:
 - ◆ Output power = 250 W
 - ◆ Power gain = 17 dB
 - ◆ Efficiency = 56 %
- Easy power control
- Integrated ESD protection
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

1.3 Applications

Industrial, scientific and medical applications



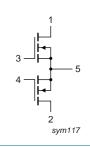
2. Pinning information

Table 2. Pinning

| Pin | Description | Simplified outline Graphic symbol |
|---------|--------------------|-----------------------------------|
| BLF6G13 | 3L-250P (SOT1121A) | |
| 1 | drain1 | |
| 2 | drain2 | 1 2 1 |
| 3 | gate1 | |
| 4 | gate2 | 5 |
| 5 | source | 11 3 4 4 |
| | | <u>'</u> |
| | | 2 sym117 |

| BLF6G13LS | -250P (SOT1121B) | |
|-----------|------------------|------------|
| 1 | drain1 | |
| 2 | drain2 | |
| 3 | gate1 | |
| 4 | gate2 | |
| 5 | source | <u>[1]</u> |





[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

| Type number | Package | | | | | |
|----------------|---------|-----------------------------------------------------------|----------|--|--|--|
| | Name | Description | Version | | | |
| BLF6G13L-250P | - | flanged LDMOST ceramic package; 2 mounting holes; 4 leads | SOT1121A | | | |
| BLF6G13LS-250P | - | earless flanged LDMOST ceramic package; 4 leads | SOT1121B | | | |

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------|----------------------|------------|------|------|------|
| V_{DS} | drain-source voltage | | - | 100 | V |
| V_{GS} | gate-source voltage | | -0.5 | +13 | V |
| I_D | drain current | | - | 42 | Α |
| T _{stg} | storage temperature | | -65 | +150 | °C |
| Tj | junction temperature | | - | 200 | °C |

BLF6G13L-250P_6G13LS-250P

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5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Тур | Unit |
|----------------------|------------------------------------------|-----------------------------------|------|------|
| R _{th(j-c)} | thermal resistance from junction to case | T_{case} = 85 °C; P_L = 250 W | 0.26 | K/W |

6. Characteristics

Table 6. DC characteristics

 $T_i = 25$ °C; per section unless otherwise specified.

| $ \begin{array}{ c c c c c c c c c c c c c c c c c c c$ | , | ' I | | | | | |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------------------|----------------------------------|-----------------------------------------------|-----|-----|-----|------|
| $\begin{array}{llllllllllllllllllllllllllllllllllll$ | Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| $\begin{array}{llllllllllllllllllllllllllllllllllll$ | $V_{(BR)DSS} \\$ | drain-source breakdown voltage | $V_{GS} = 0 \text{ V}; I_D = 1.4 \text{ mA}$ | 100 | - | - | V |
| $\begin{array}{cccccccccccccccccccccccccccccccccccc$ | $V_{GS(th)}$ | gate-source threshold voltage | $V_{DS} = 10 \text{ V}; I_D = 235 \text{ mA}$ | 1.4 | 1.8 | 2.4 | V |
| $\begin{array}{cccccccccccccccccccccccccccccccccccc$ | I _{DSS} | drain leakage current | $V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}$ | - | - | 1.4 | μΑ |
| g_{fs} forward transconductance $V_{DS} = 10 \text{ V}; I_D = 120 \text{ mA}$ - 1 - S $R_{DS(on)}$ drain-source on-state resistance $V_{GS} = V_{GS(th)} + 3.75 \text{ V};$ - 200 - $m\Omega$ | I _{DSX} | drain cut-off current | () | - | 21 | - | Α |
| $R_{DS(on)}$ drain-source on-state resistance $V_{GS} = V_{GS(th)} + 3.75 \text{ V}$; - 200 - $m\Omega$ | I _{GSS} | gate leakage current | $V_{GS} = 11 \text{ V}; V_{DS} = 0 \text{ V}$ | - | - | 240 | nΑ |
| | 9 _{fs} | forward transconductance | $V_{DS} = 10 \text{ V}; I_D = 120 \text{ mA}$ | - | 1 | - | S |
| | R _{DS(on)} | drain-source on-state resistance | | - | 200 | - | mΩ |

Table 7. RF characteristics

Mode of operation: CW; f = 1.3 GHz; RF performance at $V_{DS} = 50$ V; $I_{Dq} = 100$ mA; $T_{case} = 25$ °C; unless otherwise specified, in a class-AB production test circuit.

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------|----------------------|-------------------------|-----|-----|-----|------|
| P_{L} | output power | | 250 | - | - | W |
| V _{DS} | drain-source voltage | $P_{L} = 250 \text{ W}$ | - | - | 50 | V |
| G _p | power gain | $P_{L} = 250 \text{ W}$ | 15 | 17 | - | dB |
| RL _{in} | input return loss | $P_{L} = 250 \text{ W}$ | - | -30 | -20 | dB |
| η_{D} | drain efficiency | $P_{L} = 250 \text{ W}$ | 52 | 56 | - | % |

6.1 Ruggedness in class-AB operation

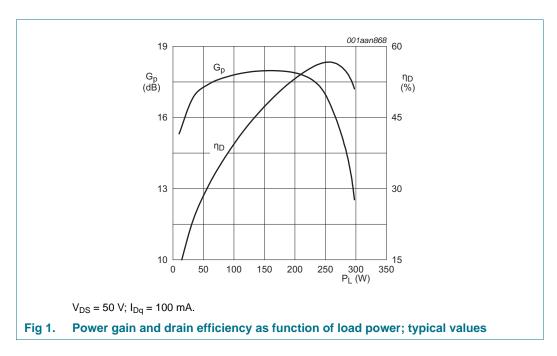
The BLF6G13L-250P and BLF6G13LS-250P are capable of withstanding a load mismatch corresponding to VSWR = 5:1 through all phases under the following conditions: $V_{DS} = 50 \text{ V}$; $I_{Dq} = 100 \text{ mA}$; $P_L = 250 \text{ W}$; f = 1.3 GHz.

BLF6G13L-250P_6G13LS-250P

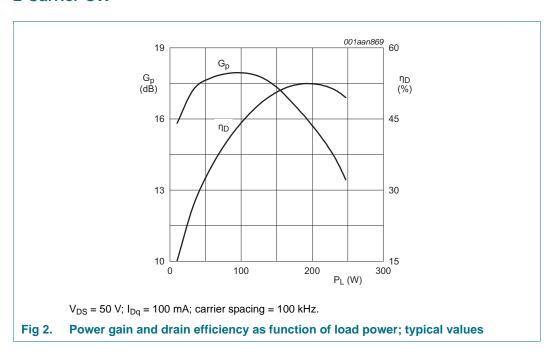
Product data sheet

7. Application information

7.1 CW

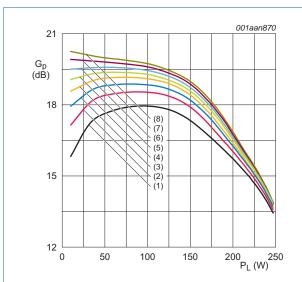


7.2 2-Carrier CW



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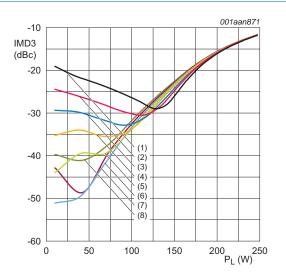
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V_{DS} = 50 V; f = 1300 MHz; carrier spacing = 100 kHz.

- (1) $I_{Dq} = 100 \text{ mA}$
- (2) $I_{Dq} = 300 \text{ mA}$
- (3) $I_{Dq} = 500 \text{ mA}$
- (4) $I_{Dq} = 700 \text{ mA}$
- (5) $I_{Dq} = 900 \text{ mA}$
- (6) $I_{Dq} = 1100 \text{ mA}$
- (7) $I_{Dq} = 1300 \text{ mA}$
- (8) $I_{Dq} = 1500 \text{ mA}$

Fig 3. Power gain as a function of load power; typical values



V_{DS} = 50 V; f = 1300 MHz; carrier spacing = 100 kHz.

- (1) $I_{Dq} = 100 \text{ mA}$
- (2) $I_{Dq} = 300 \text{ mA}$
- (3) $I_{Dq} = 500 \text{ mA}$
- (4) $I_{Dq} = 700 \text{ mA}$
- (5) $I_{Dq} = 900 \text{ mA}$
- (6) $I_{Dq} = 1100 \text{ mA}$
- (7) $I_{Dq} = 1300 \text{ mA}$ (8) $I_{Dq} = 1500 \text{ mA}$
- Fig 4. Third order intermodulation distortion as a function of load power; typical values

7.3 Impedance information

Table 8. Typical impedance

Typical values valid per section unless otherwise specified.

| f | Z _S | Z _L optimized for G _p | Z_L optimized for η_D |
|------|----------------|---------------------------------------------|------------------------------|
| MHz | Ω | Ω | Ω |
| 1200 | 3.03 – j8.15 | 2.03 – j0.25 | 1.46 – j0.47 |
| 1300 | 4.06 – j9.52 | 1.67 – j0.92 | 1.19 – j0.95 |
| 1400 | 7.00 – j9.61 | 1.50 – j1.48 | 1.22 – j1.49 |

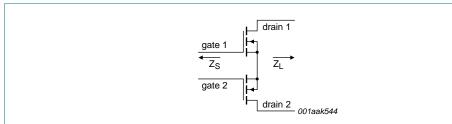


Fig 5. Definition of transistor impedance

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7.4 Circuit information

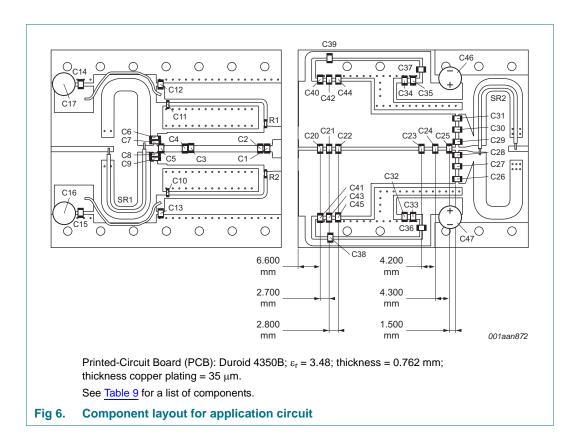
Table 9. List of components For application circuit see Figure 6.

| - | | | |
|-------------------------------------------|-----------------------------------|------------------|---------------|
| Component | Description | Value | Remarks |
| C1, C2 | multilayer ceramic chip capacitor | 1.9 pF | [1] |
| C3, C4 | multilayer ceramic chip capacitor | 4.7 pF | [1] |
| C5 | multilayer ceramic chip capacitor | 10 pF | [1] |
| C6, C7, C8, C9, C10, C11, C38, C39 | multilayer ceramic chip capacitor | 56 pF | [1] |
| C12, C13 | multilayer ceramic chip capacitor | 100 pF | [2] |
| C14, C15, C32, C34 | multilayer ceramic chip capacitor | 1 nF | [2] |
| C16, C17 | electrolytic capacitor | 10 μ F; 50 V | 220 X5R |
| C20, C21, C22, C23 | multilayer ceramic chip capacitor | 3.0 pF | [1] |
| C40, C41 | multilayer ceramic chip capacitor | 2.4 pF | [1] |
| C42, C43, C44, C45 | multilayer ceramic chip capacitor | 2.7 pF | [1] |
| C24 | multilayer ceramic chip capacitor | 0.8 pF | [1] |
| C25 | multilayer ceramic chip capacitor | 0.6 pF | [1] |
| C26, C27, c28, C29, C30, C31, C33, C35 | multilayer ceramic chip capacitor | 100 pF | [1] |
| C36, C37 | multilayer ceramic chip capacitor | 20 nF | [3] |
| C46, C47 | electrolytic capacitor | 100 μF; 63 V | |
| R1, R2 | SMD resistor 0603 | 5.1 Ω | UT-141C-25-TP |
| SR1 | COAX | 25 Ω | UT-141C-35-TP |
| SR2 | COAX | 35 Ω | |
| | | | |

^[1] American Technical Ceramics type 800B or capacitor of same quality.

^[2] American Technical Ceramics type 100B or capacitor of same quality.

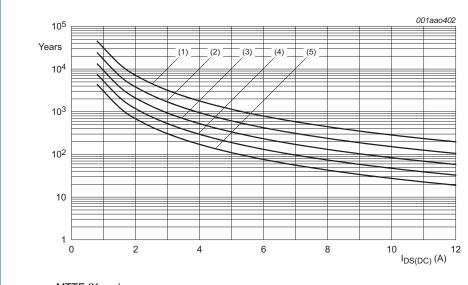
^[3] American Technical Ceramics type 200B or capacitor of same quality.



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8. Test information

8.1 Reliability



MTTF (Years)

The reliability at pulsed conditions can be calculated as follows: MTTF x 1 / δ .

- (1) $T_j = 130 \, ^{\circ}C$
- (2) $T_j = 140 \, ^{\circ}C$
- (3) $T_j = 150 \, ^{\circ}C$
- (4) $T_j = 160 \,^{\circ}C$
- (5) $T_j = 170 \, ^{\circ}C$

Fig 7. Electromigration (I_{DS(DC)}, total device)

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9. Package outline

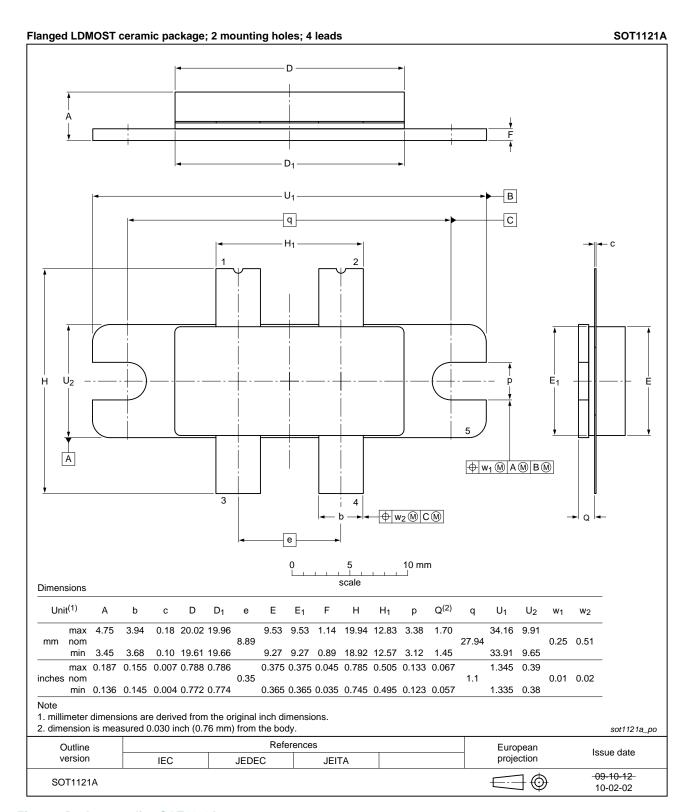


Fig 8. Package outline SOT1121A

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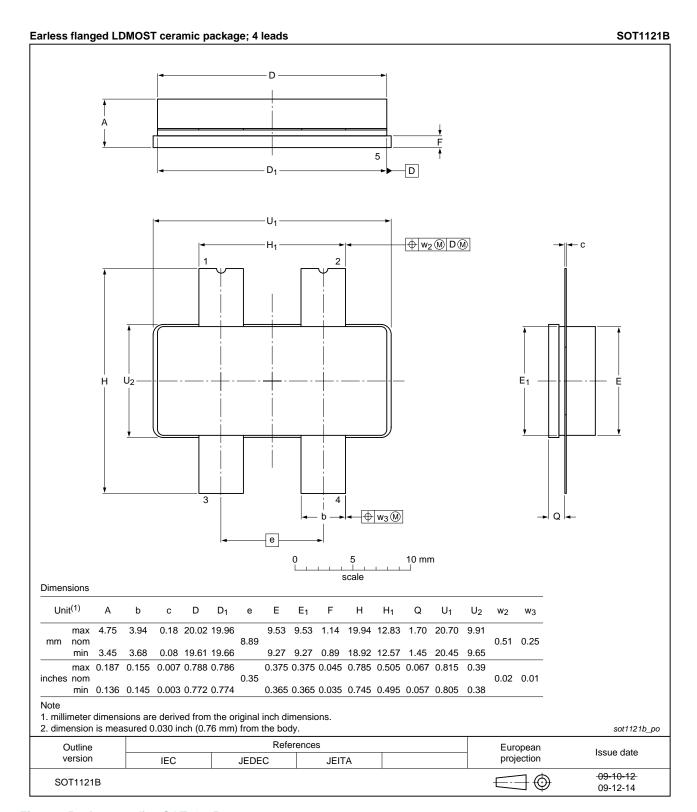


Fig 9. Package outline SOT1121B

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10. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

11. Abbreviations

Table 10. Abbreviations

| Acronym | Description |
|---------|---------------------------------------------------------|
| CW | Continuous Wave |
| LDMOS | Laterally Diffused Metal-Oxide Semiconductor |
| LDMOST | Laterally Diffused Metal-Oxide Semiconductor Transistor |
| MTTF | Mean Time To Failure |
| RF | Radio Frequency |
| SMD | Surface Mount Device |
| VSWR | Voltage Standing-Wave Ratio |
| | |

12. Revision history

Table 11. Revision history

| • | | | | |
|-------------------------------|--------------|--------------------------|------------------------------|-----------------------------------|
| Document ID | Release date | Data sheet status | Change notice | Supersedes |
| BLF6G13L-250P_6G13LS-250P v.3 | 20111014 | Product data sheet | - | BLF6G13L-250P_ 6G13LS-250P v.2 |
| Modifications: | • Table 6 on | page 3: Several values | have been updated | |
| | • Table 7 on | page 3: The minimum | value for η_{D} has bee | n updated |
| | • Section 8. | 1 on page 8: This sectio | n has been added | |
| BLF6G13L-250P_6G13LS-250P v.2 | 20110321 | Objective data sheet | - | BLF6G13L-250P_ |
| | | | | 6G13LS-250P v.1 |
| BLF6G13L-250P_6G13LS-250P v.1 | 20101102 | Objective data sheet | - | - |
| | | | | |

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13. Legal information

13.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
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- [2] The term 'short data sheet' is explained in section "Definitions"
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